PCN Number: 20150313			7004B				ı	PCN D	ate:	10/06/2015		
Title: DLPA3000 & DLPA300				A3005 A	3 R	edesign						
Customer Contact: Dlp			Dlp_	pcn_tea	m@l	<u>ist.ti.com</u>	Dept:			DLP® CQE		
Proposed 1 st Ship Date:			ate:	August 6, 2015					May 6, 2015			
Change Type:												
Assembly Site				Design				Wafer Bump Site				
Assembly Process				☐ Data Sheet				Wafer Bump Material				
Assembly Materials				Part number change				Wafer Bump Process				
Mechanical Specification			n	Test Site				Wafer Fab Site				
Packing/Shipping/Labeling			Test Process				Wafer Fab Materials					
										Wafe	r Fab l	Process
PCN Details												

Description of Change:

Revision B is to inform completion of system validation on DLPA3005 A3 and announce final notification for qualification of the DLPA3005 A3 Re-design.

Texas Instruments Incorporated is announcing final notification for qualification of the DLPA3000 A3 Re-design. System validation is in progress on DLPA3005. A final PCN addendum will be provided for DLPA3005 upon completion of the system validation.

The First Ship Date is updated as indicated in the initial PCN addendum.

Reason for Change:

Design Enhancements

- -Low Vin to allow 6VIN, supports dual battery implementations.
- -High Vin to allow +20VIN FOR PAD 3000
- -Activate all 3GP ANC Bucks
- * Texas Instruments was unable to incorporate the activation of all three General Purpose (GP) bucks in DLPA3000 A3 design change. General Purpose Buck2 (PWR6) is currently supported as stated in the data sheet.
- * On DLPA3005, System Validation is in progress. A final PCN addendum will be provided for DLPA3005 upon completion of the system validation. System Validation is complete on DLPA3005. Texas Instruments was unable to incorporate the activation of all three General Purpose (GP) bucks in DLPA3005 A3 design change. General Purpose Buck2 (PWR6) is currently supported as stated in the data sheet.

Anticipated impact on Form, Fit, Function, Quality or Reliability (positive / negative):

Additional Functions - See Reasons for Change section directly above.

Changes to product identification resulting from this PCN:

The part will be marked with revision D instead of revision C. Example:

- Current Marking DLPA3000C will become DLPA3000D
- Current Marking DLPA3005C will become DLPA3005D

Product Affected:

DLPA3000CPFD, DLPA3000CPFDR, DLPA3005CPFD, DLPA3005CPFDR, PAD3000A2PFD, PAD3000A2PFDR, PAD3005A2PFDR, PAD3005A2PFDR

Qualification Data							
This qualification has been developed for the validation of this change. The qualification data validates that the proposed change meets the applicable released technical specifications.							
Qualification Schedule:	Start:	May 25, 2015	End:	June 25, 2015			
Qual Vehicle:	Device V	/ehicle (DLPA3000D &	DLPA30	05D)			
Qualification:	Test Resu	ılts					

Qualification Data

Test	Conditions	Read Points	Sample Size/ Results
A. Life Test:			
High Temperature Operating Life	140C	480 hours	QBS ⁽¹⁾
B. Environmental Tests:			
Preconditioning + Temperature Cycling:			
(a) Preconditioning	MSL2; 85C/60%RH	168hrs	QBS ⁽¹⁾
(b) Temperature Cycling	-65C/+150C	500 cycles	QBS ⁽¹⁾
ESD	НВМ	+/- 2000V	QBS ⁽¹⁾
ESD	CDM	+/- 750V	QBS ⁽¹⁾
Electrical Characterization	Per data sheet		30 (each)/ Pass
Latch Up	70C	+/- 100mA	QBS ⁽¹⁾
C. Inspection Tests:			
X-Ray	Top view only		QBS ⁽¹⁾
D. Other			
Manufacturing Qual	TITL ERTP		1 lot (each)/ Pass

Notes:

1) QBS (Qual by Similarity) to DLPA3000C

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

Location	E-Mail
DLP PCN Team	dlp_pcn_team@ti.com
USA	PCNAmericasContact@list.ti.com
Europe	PCNEuropeContact@list.ti.com
Asia Pacific	PCNAsiaContact@list.ti.com
Japan	PCNJapanContact@list.ti.com